

June 1998 Revised October 1998

GTLP6C816 GTLP-to-TTL 1:6 Clock Driver

General Description

The GTLP6C816 is a clock driver that provides TTL to GTLP signal level translation (and vice versa). The device provides a high speed interface between cards operating at TTL logic levels and a backplane operation at GTLP logic levels. High speed backplane operation is a direct result of GTLP's reduced output swing (<1V), reduced input threshold levels and output edge rate control. The edge rate control minimizes bus settling time. GTLP is a Fairchild Semiconductor derivative of the Gunning Transceiver logic (GTL) JEDEC standard JESD8-3.

Fairchild's GTLP has internal edge-rate control and is process, voltage, and temperature (PVT) compensated. Its function is similar to BTL and GTL but with different output levels and receiver threshold. GTLP output LOW level is

typically less than 0.5V, the output level HIGH is 1.5V and the receiver threshold is 1.0V. $\,$

Features

- Interface between TTL and GTLP logic levels
- Edge Rate Control to minimize noise on the GTLP port
- Power up/down high impedance for live insertion
- 1:6 fanout clock driver for TTL port
- 1:2 fanout clock driver for GTLP port
- TTL compatible driver and control inputs
- Flow through pinout optimizes PCB layout
- Open drain on GTLP to support wired-or connection
- Recommended Operating Temperature –40°C to +85°C

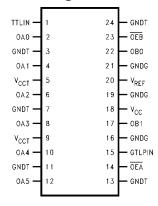
Ordering Code:

Order Number	Package Number	Package Description
GTLP6C816MTC	MTC24	24-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 4.4mm Wide

Pin Descriptions

Pin Names	Description		
TTLIN, GTLPIN	Clock Inputs (TTL and GTLP respectively)		
OEB	Output Enable (Active LOW) GTLP Port (TTL Levels)		
OEA	Output Enable (Active LOW) TTL Port (TTL Levels)		
V _{CCT} .GNDT	TTL Output Supplies (5V)		
V _{CC}	Internal Circuitry V _{CC} (5V)		
GNDG	OBn GTLP Output Grounds		
V _{REF}	Voltage Reference Input		
OA0-OA5	TTL Buffered Clock Outputs		
OB0-OB1	GTLP Buffered Clock Outputs		

Connection Diagram



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Functional Description

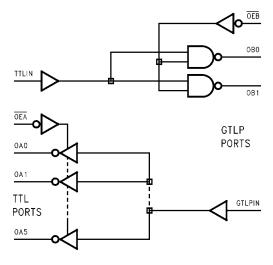
The GTLP6C816 is a clock driver providing TTL-to-GTLP clock translation, and GTLP-to-TTL clock translation in the same package. The TTL-to-GTLP direction is a 1:2 clock driver path with a single Enable pin (OEB). For the GTLP-to-TTL direction the clock receiver path is a 1:6 buffer with a single Enable control (OEA). Data polarity is inverting for both directions.

Truth Tables

Inputs		Outputs	
TTLIN	OEB	OBn	
Н	L	L	
L	L	Н	
Х	Н	High Z	

Inputs		Outputs
GTLPIN	OEA	OAn
Н	L	L
L	L	Н
Х	Н	High Z

Logic Diagram



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Absolute Maximum Ratings(Note 1)		Recommended Operating		
Supply Voltage (V _{CC})	-0.5V to +7.0V	Conditions (Note 3)		
DC Input Voltage (V _I)	-0.5V to +7.0V	Supply Voltage V _{CC}	4.75V to 5.25V	
DC Output Voltage (V _O)		Bus Termination Voltage (V _{TT})		
Outputs 3-STATE	-0.5V to $+7.0V$	GTLP	1.47V to 1.53V	
Outputs Active (Note 2)	-0.5V to +7.0V	V_{REF}	0.98V to 1.02V	
DC Output Sink Current into		Input Voltage (V _I) on INA-Port		
OA-Port I _{OL}	48 mA	and Control Pins	0.0V to 5.5V	
DC Output Source Current		HIGH Level Output Current (IOH)		
from OA-Port I _{OH}	-48 mA	OA-Port	−24 mA	
DC Output Sink Current into		LOW Level Output Current (I _{OL})		
OB-Port in the LOW State I _{OL}	80 mA	OA-Port	+24 mA	
DC Input Diode Current (I _{IK})		OB-Port	+34 mA	
V ₁ < 0V	−50 mA	Operating Temperature (T _A)	-40°C to $+85^{\circ}\text{C}$	
DC Output Diode Current (I _{OK})		Note 1: Absolute Maximum continuous rating		
$V_{O} < 0V$ –50 n		which damage to the device may occur. Exposure to these conditions or conditions beyond those indicated may adversely affect device reliability.		
V _O > V _{CC}	+50 mA	Functional operation under absolute maxim	,	
ESD Rating	> 2000V	implied. Note 2: I _o Absolute Maximum Rating must be	observed	
Storage Temperature (T _{STG})	–65°C to +150°C	Note 3: Unused input must be held high or low		

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DC Electrical Characteristics

Over Recommended Operating Free-Air Temperature Range, $V_{\mbox{REF}} = 1.0V$ (unless otherwise noted).

	Symbol	Test C	onditions	Min	Typ (Note 4)	Max	Units
V _{IH}	GTLPIN	1		V _{REF} +0.05	 	V _{TT}	
	Others			2.0			V
V _{IL}	GTLPIN			0.0		V _{REF} -0.05	V
	Others					0.8	
V _{REF}	GTLP				1.0		
(Note 5)	GTL				0.8		V
V _{TT}	GTLP				1.5		.,
(Note 5)	GTL				1.2		V
V _{IK}		V _{CC} = 4.75V	I _I = -18 mA			-1.2	V
V _{OH}	OAn-Port	V _{CC} = 4.75V	$I_{OH} = -100 \mu A$	V _{CC} -0.2			
			I _{OH} = -18 mA	2.4			V
			I _{OH} = -24 mA	2.2			
V _{OL}	OAn-Port	V _{CC} = 4.75V	I _{OL} = 100 μA			0.2	1
OL			I _{OL} = 18 mA			0.4	V
			I _{OL} = 24 mA			0.5	
V _{OL}	OBn-Port	V _{CC} = 4.75V	I _{OL} = 100 μA			0.2	V
OL.			I _{OL} = 34 mA			0.65	
I _I	TTLIN/	V _{CC} = 5.25V	V _I = 5.25V			5	
	Control Pins		$V_I = 0V$			- 5	μΑ
	GTLPIN	V _{CC} = 5.25V	$V_I = V_{TT}$			5	
			$V_I = 0$			-5	μΑ
I _{OFF}	TTLIN	V _{CC} = 0	V _I or V _O = 0V to 5.25V			100	μΑ
l _{ozh}	OAn-Port	V _{CC} = 5.25V	V _O = 5.25V			5	
	OBn-Port		V _O = 1.5V			5	μΑ
l _{OZL}	OAn-Port	$V_{CC} = 5.25V$	V _O = 0			- 5	μА
I _{CC}	OAn or	V _{CC} = 5.25V	Outputs HIGH		7	18	
	OBn Ports		Outputs LOW		7	20	mA
		$V_I = V_{CC}$ or GND	Outputs Disabled		7	20	
Δl _{CC}	TTLIN	V _{CC} = 5.25V	V _I = V _{CC} -2.1			6	mA
C _{IN}	Control Pins/GTLPIN/ TTLIN		$V_I = V_{CC}$ or 0		3.7		pF
C _{OUT}	OAn-Port		$V_I = V_{CC}$ or 0		7		pF
	OBn-Port		$V_I = V_{CC}$ or 0		7		

Note 4: All typical values are at $V_{CC} = 5.0 V$ and $T_A = 25 ^{\circ} C$.

Note 5: GTLP V_{REF} and V_{TT} are specified to 2% tolerance since signal integrity and noise margin can be significantly degraded if these supplies are noisy. In addition, V_{TT} and R_{TERM} can be adjusted to accommodate backplane impedances other than 50Ω , within the boundaries of not exceeding the DC Absolute I_{OL} ratings. Similarly V_{REF} can be adjusted to compensate for changes in V_{TT} .

AC Electrical Characteristics

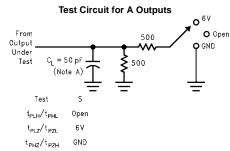
Over recommended range of supply voltage and operating free air temperature. V_{REF} = 1.0V (unless otherwise noted). C_L = 30 pF for OBn-Port and C_L = 50 pF for OAn-Port.

Symbol	From (Input)	To (Output)	Min	Typ (Note 6)	Max	Units
t _{PLH}	TTLIN	OBn	1.5	3.8	6.0	ns
t _{PHL}			1.5	2.8	5.0	115
t _{PLH}	OEB	OBn	1.5	6.4	10.5	
t _{PHL}			1.5	3.2	6.0	ns
t _{RISE}	Transition Time, OB Outputs (20% to 80%)			2.3		ns
t _{FALL}	Transition Time, OB outputs (20% to 80%)			2.3		ns
t _{RISE}	Transition Time, OA outputs (10% to 90%)			2.0		ns
t _{FALL}	Transition Time, OA outputs (10% to 90%)			2.0		ns
t _{PZH} , t _{PZL}	OEA	OAn	0.5	3.6	6.5	
t_{PLZ} , t_{PHZ}			0.5	3.8	6.5	ns
t _{PLH}	GTLPIN	OAn	1.5	4.4	6.5	
t _{PHL}			1.5	4.0	6.0	ns
t _{OSHL} , t _{OSLH} (Note 7)	Common Edge Skew			0.2	1.0	ns

Note 6: All typical values are at $V_{CC}=5.0V$ and $T_A=25^{\circ}C.$

Note 7: Skew specs are given for specific worst case V_{CC} Temp. Skew values between the OBn outputs could vary on the backplane due to loading and impedance seen by the device.

Test Circuit and Timing Waveforms



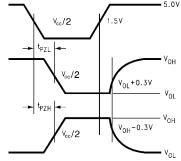
Test Circuit for B Outputs
1.5V (GTLP)
1.2V (GTL)

From Output
Under
Test
30 pF
(Notes A, B)

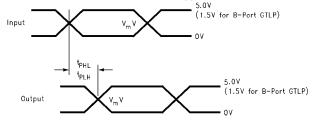
Note A: C_L includes probes and jig capacitance. Note B: For B-Port C_L = 30 pF is used for worst case.

Note A: C_L includes probes and jig capacitance.

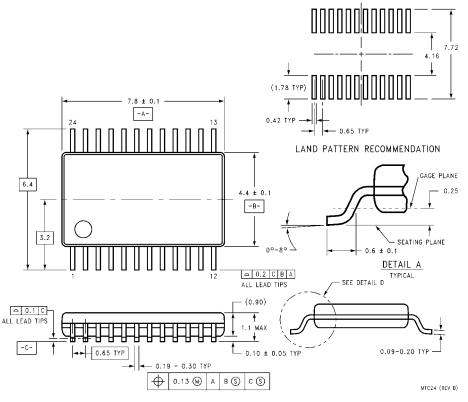
Voltage Waveforms Enable and Disable Times A-Port



Voltage Waveforms Propagation Delay (V $_{m} = V_{CC}/2$ for A-Port and 1.0 for B-Port)



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24-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 4.4mm Wide Package Number MTC24

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